

Application No.	Applicant(s)	
09/690,580	VASHCHENKO ET AL	••
Examiner	Art Unit	
Dana Farahani	2814	

SEARCHED				
Class	Subclass	Date	Examiner	
257	552	4/22/2004	DF	
257	554	4/22/2004	DF	
257	556	4/22/2004	DF	
DF257	273	4/22/2004	DF	
257	350	4/22/2004	DF	
257	370	4/22/2004	DF	
257	355	4/22/2004	DF	
257	356	4/22/2004	DF	
257	357	4/22/2004	DF	
257	358	4/22/2004	DF	
257	359	4/22/2004	DF	
257	360	4/22/2004	DF	
257	197	4/22/2004	DF	
257	198	4/22/2004	DF	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	197	4/22/2004	DF	
257	198	4/22/2004	DF	
257	554	4/22/2004	DF	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
!257/\$.cc1s. and (ESD) and (lemitter ijnear width) and (base near wzdthl) and jtheat adj sink) ë	4/22/2004	DF
257/\$.ccls. and (heat adj sink with base)	4/22/2004	DF
257/\$.ccls. and emitter and base and ESD	4/22/2004	DF
257/\$.ccls. and (emitter) and (lbasels i near (contact) near (semiconductorl)! i and (linsulating or insulator or i! insula	4/22/2004	DF